

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128985		APPLICATION NO. 10/588,146	
INFORMATION DISCLOSURE STATEMENT							
(Use several sheets if necessary)							
				APPLICANT(S) Kenichi SHIRAISHI			
				FILING DATE August 1, 2006		GROUP 2852	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
/AM/	1	US 2004/0020782 A1	02/05/2004	Cohen et al.			
↓	2	US 6,341,007 B1	01/22/2002	Nishi et al.			
	3	US 6,400,411 B1	06/04/2002	Bayes et al.			
	4	US 6,549,269 B1	04/15/2003	Nishi et al.			
	5	US 6,591,634 B1	07/15/2003	Morizane			
	6	5,969,441	10/19/1999	Loopstra et al.			
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	8	5,825,043	10/20/1998	Suwa			
	9	5,623,853	04/29/1997	Novak et al.			
	10	5,528,118	06/18/1996	Lee			
/AM/	11	5,874,820	02/23/1999	Lee			
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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
/AM/	12	JP A 08-37149	02/06/1996	Japan	X	X	
↓	13	JP A 04-65603	03/02/1992	Japan	X		
	14	JP A 07-176468	07/14/1995	Japan	X	X	
	15	JP A 57-117238	07/21/1982	Japan	X		
	16	JP A 2002-14005	01/18/2002	Japan	X	X	
	17	JP A 11-16816	01/22/1999	Japan	X	X	
	18	JP A 06-188169	07/08/1994	Japan	X	X	
	19	JP A 10-163099	06/19/1998	Japan	X	X	
	20	JP A 10-214783	08/11/1998	Japan	X	X	
	/AM/						
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
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/AM/	21	JP A 2000-505958	05/16/2000	Japan	X	X	
↓	22	JP A 06-124873	05/06/1994	Japan	X	X	
	23	JP A 08-166475	06/25/1996	Japan	X	X	
/AM/	24	JP A 08-330224	12/13/1996	Japan	X	X	
OTHER DOCUMENTS							
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